
7544 Group

Timer A Operation (Pulse Width HL Continuously Measurement Mode)

1. Abstract

The following article introduces and shows an application example of pulse width HL continuously measurement mode of timer A.

2. Introduction

The explanation of this issue is applied to the following condition:
Applicable MCU: 7544 Group

3. Contents

Outline: An input signal is detected by using the pulse width HL continuously measurement mode.

Specifications: Whether a normal-range signal is input or not is judged by measuring a pulse width input from the P0₀/CNTR1 pin.

$f(X_{IN})/16$ ($f(X_{IN}) = 6.4 \text{ MHz}$) is used as the count source, and “H” and “L” pulse width of the input pulse are measured by using the pulse width HL continuously measurement mode. When the following conditions are satisfied, it is recognized as a normal value. When the following conditions are not satisfied, it is recognized as an unusual value.

$200 \text{ ms} \leq \text{“H” pulse width} < 1.2 \text{ s}$

$600 \text{ ms} \leq \text{“L” pulse width of} < 2.2 \text{ s}$

$1.0 \text{ s} \leq \text{one period (‘‘H’’ pulse width + ‘‘L’’ pulse width)} < 3.0 \text{ s}$

Operation clock: $f(X_{IN}) = 6.4 \text{ MHz}$, high-speed mode

3.1 Example of Peripheral Circuit

Figure 1 shows an example of a peripheral circuit.

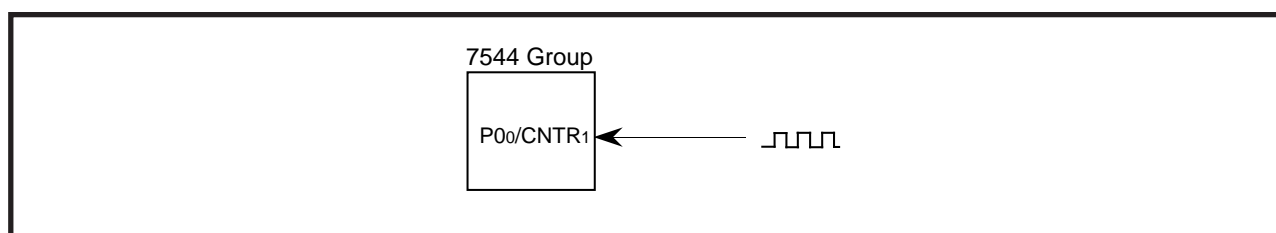


Figure 1 Example of peripheral circuit

3.2 Operation Timing When Pulse is Input

Figure 2 shows an operation timing when a pulse is input.

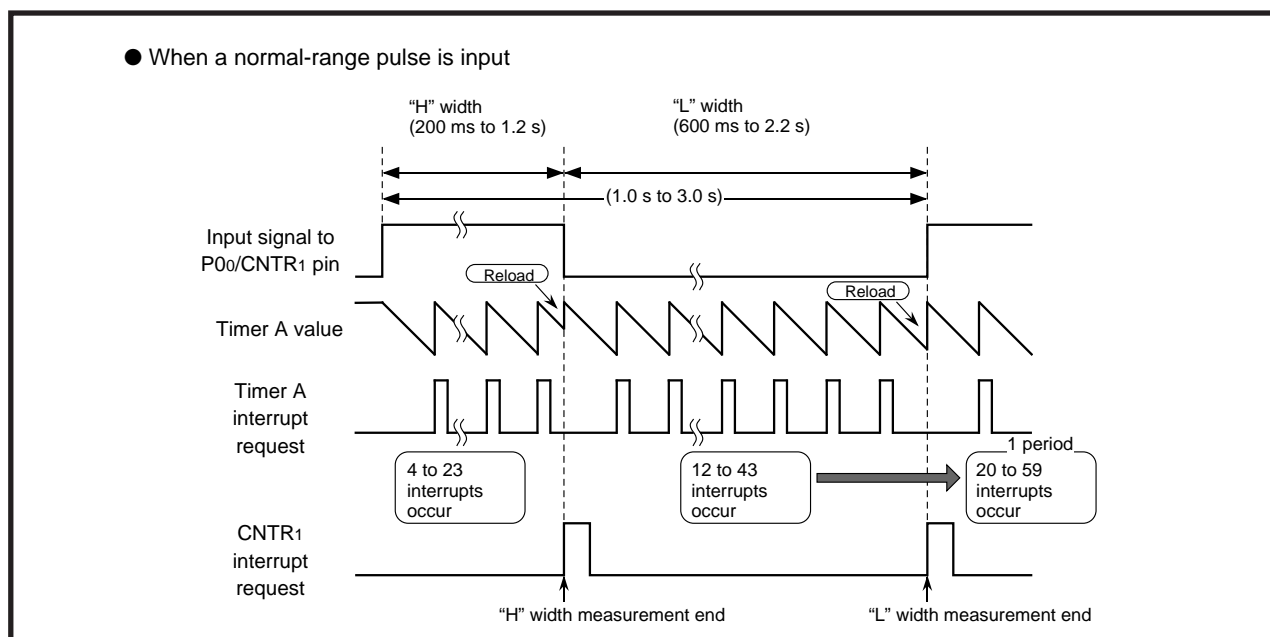


Figure 2 Operation timing when pulse is input

3.3 Example of Control Procedure

Figure 3 and Figure 4 show an example of control procedure.

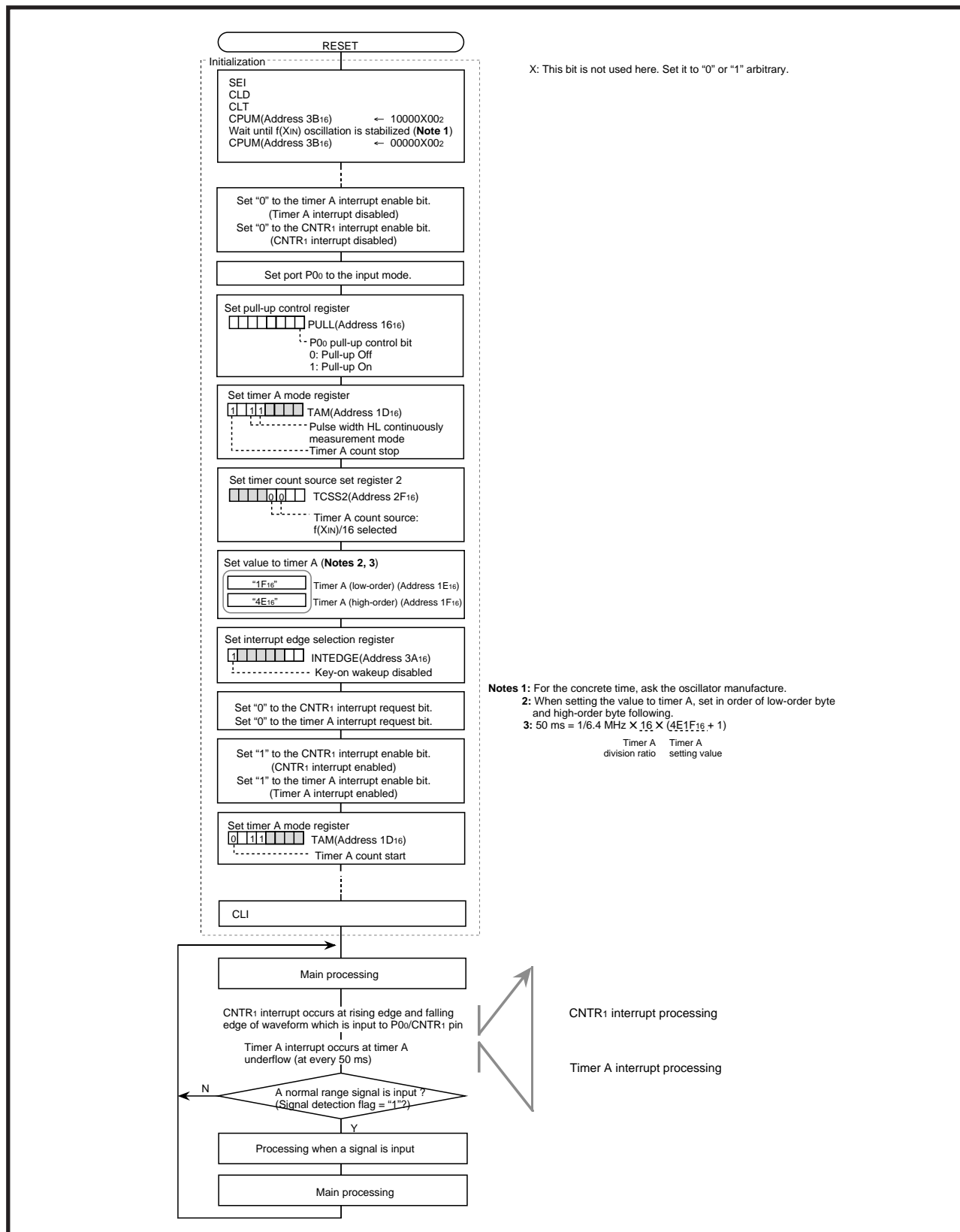


Figure 3 Example of control procedure (1)

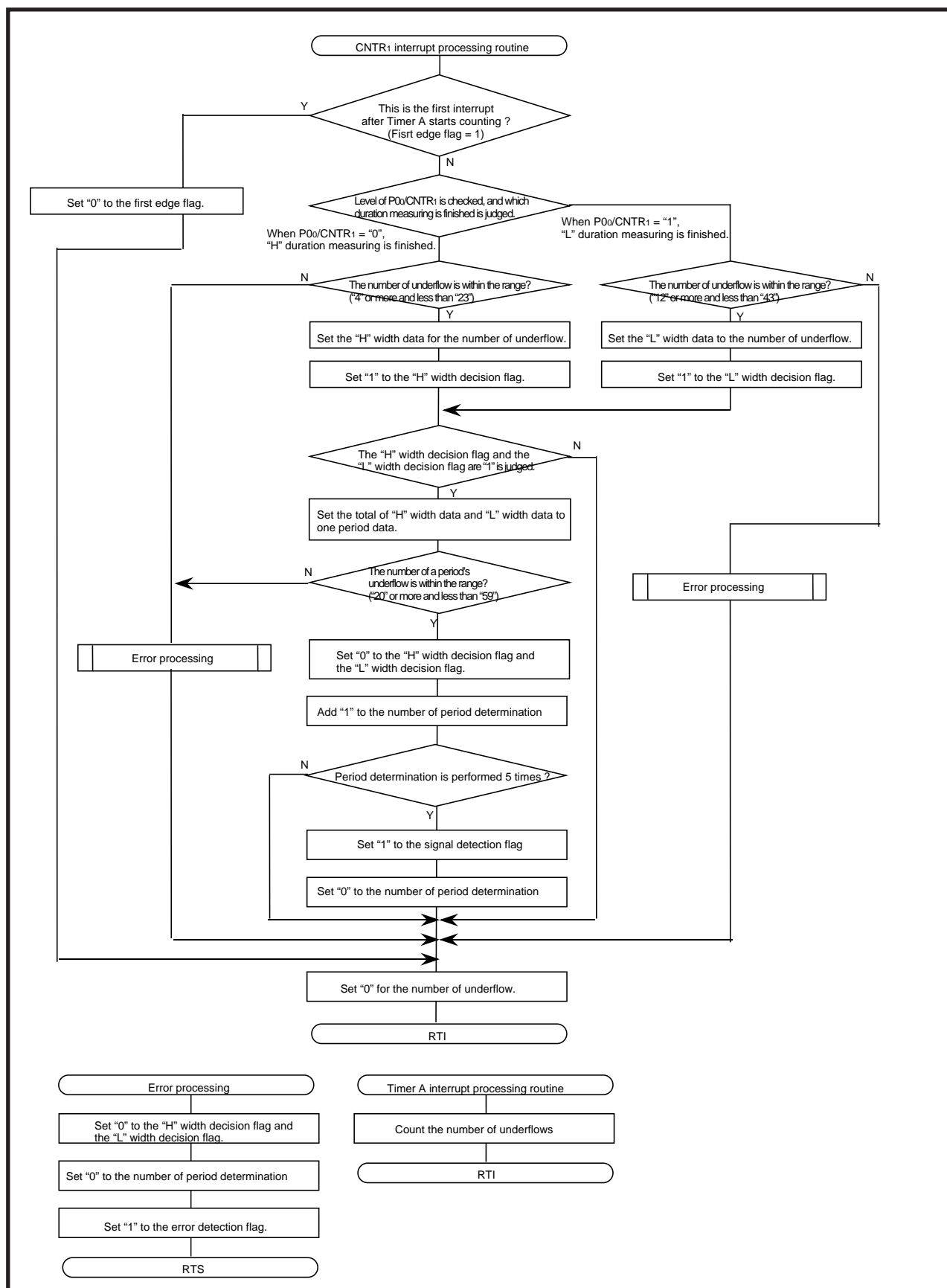


Figure 4 Example of control procedure (2)

4. Sample Programming Code

[Reset Start •• Main Routine Process]

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RESET:
    SEI                                ; Interrupt disable
    CLD
    CLT
;
    LDX  #$FF                          ; Set stack bottom
    TXS
;
    LDM  #%10000000,CPUM               ; Set CPU mode register
;
; Wait f(XIN) oscillation stabilizing time
;
    LDM  #%00000000,CPUM              ; Set CPU mode register
;
    LDA  #0
    LDX  #>RAM_top
RAM_clear:
    STA  $00,X
    INX
    BNE  RAM_clear
;
    CLB  2,ICON2                       ; TimerA interrupt disable
    CLB  6,CNTR1                       ; CNTR1 interrupt disable
;
    LDM  #%00000000,P0D               ; Set Port P0 direction register
;
    CLB  0,PULL                        ; Port P00 Pull_up off
;
    LDM  #%10110000,TAM               ; Set Timer A mode register
;
    LDM  #%00000000,TCSS2             ; Set Timer count source set register 2
;
    LDM  #$1F,TAL                     ; Set Timer A (low-order)
    LDM  #$4E,TAH                     ; Set Timer A (high-order)
;
    SEB  7,INTEDGE                    ; disable key on wake-up interrupt
;
    CLB  2,IREQ2                       ; TimerA interrupt request clear
    CLB  6,IREQ1                       ; CNTR1 interrupt request clear
    SEB  2,ICON2                       ; TimerA interrupt enable
    SEB  6,ICON1                       ; CNTR1 interrupt enable
;
    SEB  f_first_edge                  ; ignore first edge
;
    CLB  7,TAM                        ; start timer A count
;
    CLI
;
__MAIN:
    BBC  f_RING,__MAIN
    ;
    ; process
    ;
    BRA  __MAIN
;

```

5. Reference

Data Sheet

7544 Group Data sheet

7544 Group Data sheet (QzROM Version)

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REVISION HISTORY	7544 Group Timer A Operation (Pulse Width HL Continuously Measurement Mode)
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Rev.	Date	Description	
		Page	Summary
1.00	Apr 01, 2003	-	First Edition issued
2.00	Nov 12, 2004	2-4	Contents: Specifications and Figures 1 to 3 revised.
		5	Sample Programming Code added.

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